

Search Notes

Application/Control No.

10/676,967

Examiner

Nam V. Nguyen

Applicant(s)/Patent under
Reexamination

CHANDLEY, ADRIAN MARK

Art Unit

2635

SEARCHED

Class	Subclass	Date	Examiner
340	5.31	12/19/2006	NN
340	5.21	12/19/2006	NN
340	5.28	12/19/2006	NN
340	5.3+	12/19/2006	NN
340	571	12/19/2006	NN
340	572.1	12/19/2006	NN
340	572.8	12/19/2006	NN
340	426,567	12/19/2006	NN
713	201	12/19/2006	NN
235	382	12/19/2006	NN
455	410-411	12/19/2006	NN
455	418	12/19/2006	NN
455	343	2/6/2006	NN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Search EAST: USPAT; US-PUB; EPO; JPO and Derwent. (UPDATED SEARCH)	12/19/2006	NN
Consult with Tai Nguyen (art unit 2612)	12/18/2006	NN